Notice of References Cited Application/Control No. 10/743,887 Examiner BEN H. LIU Applicant(s)/Patent Under Reexamination DAYAL ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,694,452 A	09-1987	Beckinger et al.	370/360
*	В	US-6,442,250 B1	08-2002	Troen-Krasnow et al.	379/93.15
*	С	US-2003/0154154 A1	08-2003	Sayal et al.	705/37
*	D	US-6,650,660 B1	11-2003	Koehler et al.	370/503
*	Е	US-2004/0034703 A1	02-2004	Phadke, Abhay N.	709/224
*	F	US-2004/0047286 A1	03-2004	Larsen et al.	370/216
*	G	US-7,274,926 B1	09-2007	Laumen et al.	455/414.1
*	Ι	US-7,274,711 B2	09-2007	Kajizaki et al.	370/473
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.